



Features:

- Glass passivated chip junction
- High efficiency, low V_F
- High current capability
- High reliability
- High surge current capability
- For use in low voltage, high frequency inverter, free wheeling, and polarity protection application

Specifications:

Mechanical Data:

Cases	: Moulded plastic DO-41
Lead	: Pure tin plated, lead free, solderable per MIL-STD-202, Method 208 guaranteed
Polarity	: Colour band denotes cathode end
High temperature soldering guaranteed	: 260°C/10 seconds/0.375", (9.5mm) lead lengths at 5lbs., (2.3kg) tension
Weight	: 0.34g

Maximum Ratings and Electrical Characteristics:

Rating at 25°C ambient temperature unless otherwise specified.

Single phase, half wave, 60Hz, resistive or inductive load.

For capacitive load, derate current by 20%.

Type Number	Symbol	HER102G	HER104G	HER106G	HER108G	Units
Maximum Recurrent Peak Reverse Voltage	V _{RRM}	100	300	600	1,000	V
Maximum RMS Voltage	V _{RMS}	70	210	420	700	
Maximum DC Blocking Voltage	V _{DC}	100	300	600	1,000	
Maximum Average Forward Rectified Current 0.375" (9.5mm) Lead Length at T _A = 55°C	I _(AV)	1				A
Peak Forward Surge Current, 8.3ms Single Half Sine-wave Superimposed on Rated Load (JEDEC method)	I _{FSM}	30				
Maximum Instantaneous Forward Voltage at 1A	V _F	1		1.7		V

Diode Fast



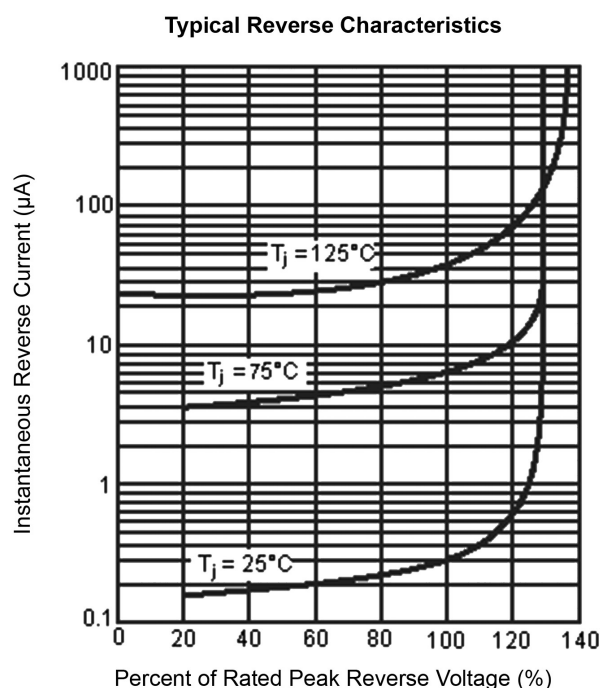
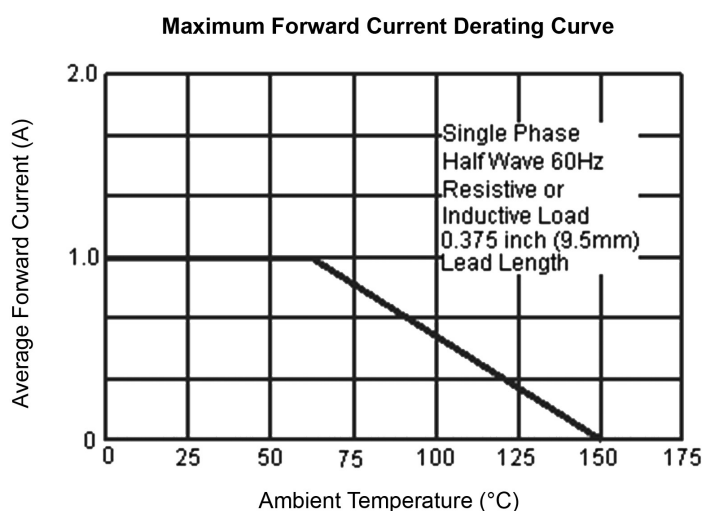
Type Number	Symbol	HER102G	HER104G	HER106G	HER108G	Units
Maximum DC Reverse Current at T _A = 25°C at Rated DC Blocking Voltage at T _A = 125°C	I _R	5 150				μA μA
Maximum Reverse Recovery Time (Note 1)	T _{rr}	50		75		nS
Typical Junction Capacitance (Note 2)	C _j	15		10		pF
Typical Thermal Resistance	R _{θJA} R _{θJC}	70 15				°C/W
Operating Temperature Range	T _J	-65 to +150				°C
Storage Temperature Range	T _{STG}					

Note: 1. Reverse Recovery Test Conditions: $I_F = 0.5\text{A}$, $I_R = 1\text{A}$, $I_{RR} = 0.25\text{A}$.

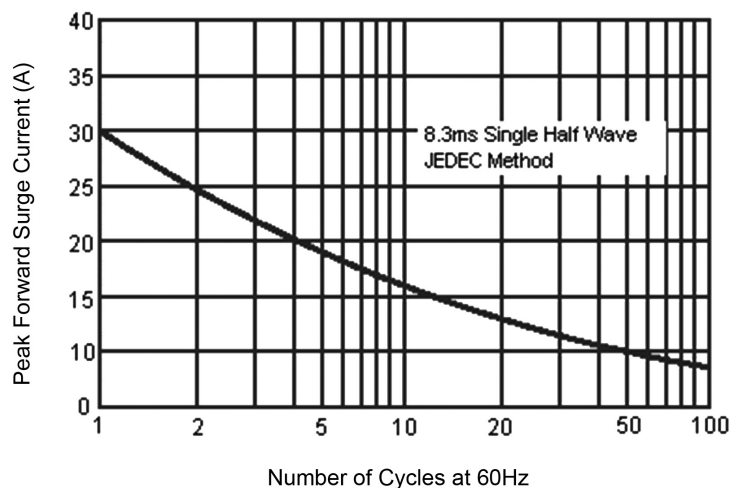
Note: 2. Measured at 1MHz and Applied Reverse Voltage of 4V DC.

Note: 3. Mount on Cu-Pad Size 5mm $\times$ 5mm on PCB.

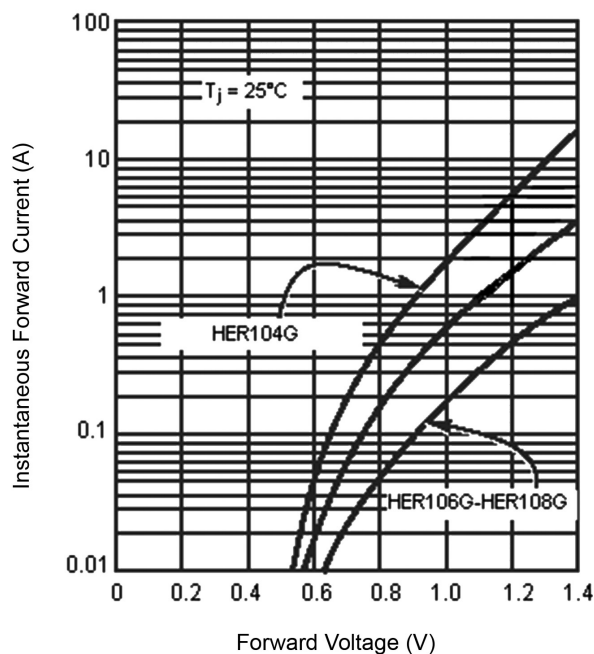
Ratings and Characteristic Curves (HER102G, HER104G, HER106G, HER108G)



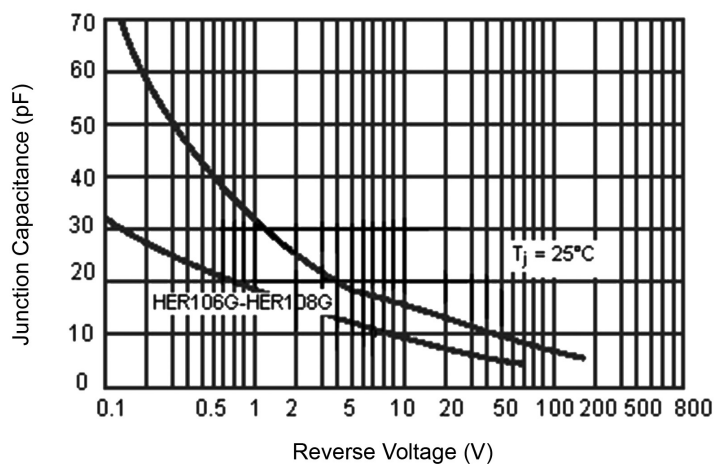
Maximum Non-Repetitive Forward Surge Current



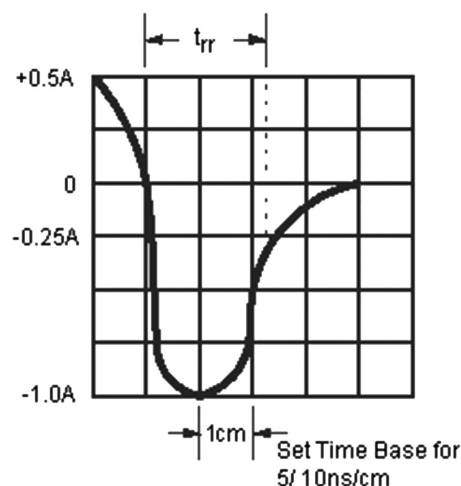
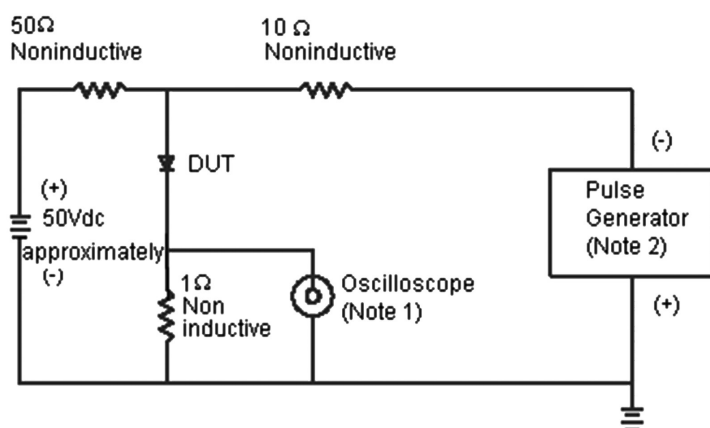
Typical Instantaneous Forward Characteristics



Typical Junction Capacitance



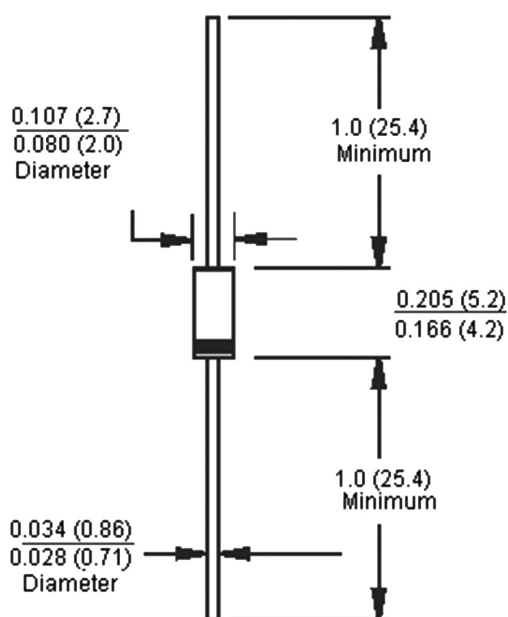
Reverse Recovery Time Characteristic and Test Circuit Diagram



Note: 1. Rise Time = 7ns Maximum Input Impedance = 1MΩ 22pf

Note: 2. Rise Time = 10ns Maximum Source Impedance = 50Ω

DO-41



Dimensions : Inches (Millimetres)

Part Number Table

Description	Part Number
Diode, Fast, 1A, 100V	HER102G
Diode, Fast, 1A, 300V	HER104G
Diode, Fast, 1A, 600V	HER106G
Diode, Fast, 1A, 1,000V	HER108G

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